

Single N-channel MOSFET

ELM14450AA-N

■ General description

ELM14450AA-N uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and low gate resistance.

■ Features

- $V_{ds}=40V$
- $I_d=6.6A$ ($V_{gs}=10V$)
- $R_{ds(on)} < 30m\Omega$ ($V_{gs}=10V$)
- $R_{ds(on)} < 43m\Omega$ ($V_{gs}=4.5V$)

■ Maximum absolute ratings

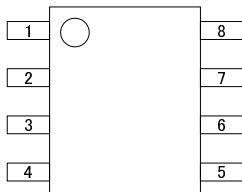
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	40	V	
Gate-source voltage	V_{gs}	± 20	V	
Continuous drain current	I_d	6.6	A	1
		5.2		
Pulsed drain current	I_{dm}	20	A	2
Power dissipation	P_d	2.5	W	
		1.6		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	°C	

■ Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$t \leq 10s$	$R_{\theta ja}$	38	50	°C/W	1
Maximum junction-to-ambient	Steady-state		69	80	°C/W	
Maximum junction-to-lead	Steady-state	$R_{\theta jl}$	24	30	°C/W	3

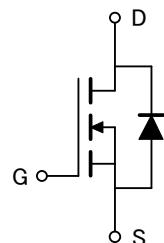
■ Pin configuration

SOP-8 (TOP VIEW)



Pin No.	Pin name
1	SOURCE
2	SOURCE
3	SOURCE
4	GATE
5	DRAIN
6	DRAIN
7	DRAIN
8	DRAIN

■ Circuit



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■ Electrical characteristics

T_a=25°C

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-source breakdown voltage	BVdss	Id=250 μA, Vgs=0V	40			V
Zero gate voltage drain current	Idss	Vds=32V			1	μ A
		Vgs=0V	T _j =55°C		5	
Gate-body leakage current	Igss	Vds=0V, Vgs=±20V			100	nA
Gate threshold voltage	Vgs(th)	Vds=Vgs, Id=250 μ A	1.0	2.3	3.0	V
On state drain current	Id(on)	Vgs=10V, Vds=5V	20			A
Static drain-source on-resistance	Rds(on)	Vgs=10V		21.7	30.0	m Ω
		Id=6.6A	T _j =125°C	37.0		
		Vgs=4.5V, Id=5.5A		31.3	43.0	
Forward transconductance	Gfs	Vds=5V, Id=6.6A		23		S
Diode forward voltage	Vsd	Is=1A, Vgs=0V		0.77	1.00	V
Max. body-diode continuous current	Is				6.6	A
DYNAMIC PARAMETERS						
Input capacitance	Ciss	Vgs=0V, Vds=20V, f=1MHz		404		pF
Output capacitance	Coss			95		pF
Reverse transfer capacitance	Crss			37		pF
Gate resistance	Rg	Vgs=0V, Vds=0V, f=1MHz		2.7		Ω
SWITCHING PARAMETERS						
Total gate charge (10V)	Qg	Vgs=10V, Vds=20V, Id=6.6A		9.3		nC
Total gate charge (4.5V)	Qg			4.6		nC
Gate-source charge	Qgs			1.6		nC
Gate-drain charge	Qgd			2.5		nC
Turn-on delay time	td(on)	Vgs=10V, Vds=20V R _l =3 Ω, R _{gen} =3 Ω		4.3		ns
Turn-on rise time	tr			3.4		ns
Turn-off delay time	td(off)			15.0		ns
Turn-off fall time	tf			2.8		ns
Body diode reverse recovery time	trr	I _f =6.6A, dI/dt=100A/μ s		21.2		ns
Body diode reverse recovery charge	Qrr	I _f =6.6A, dI/dt=100A/μ s		15.8		nC

NOTE :

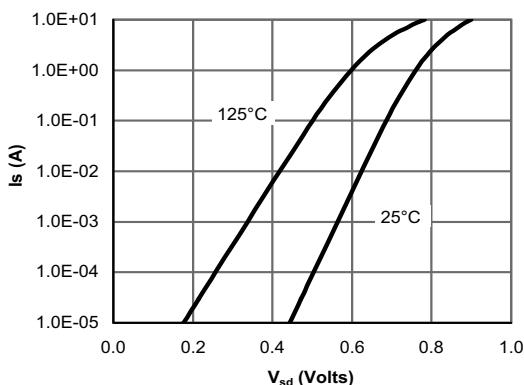
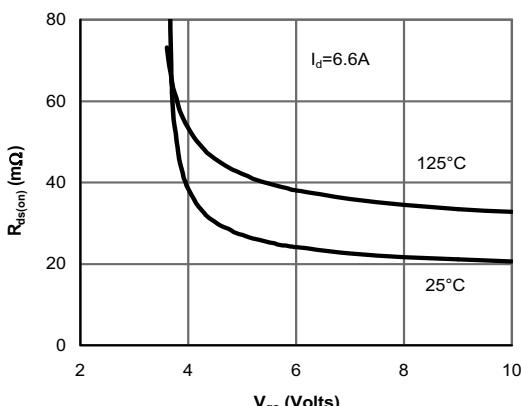
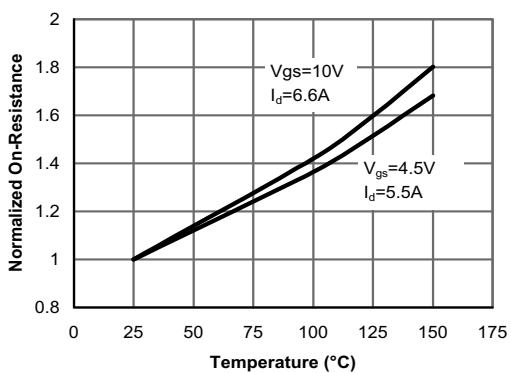
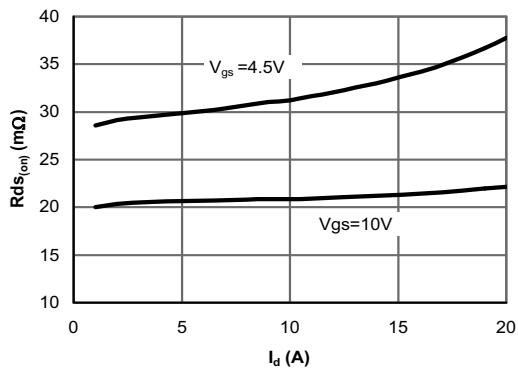
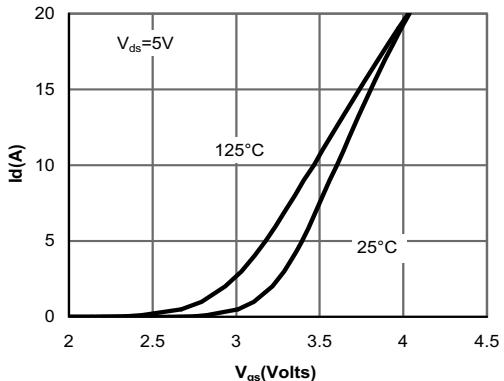
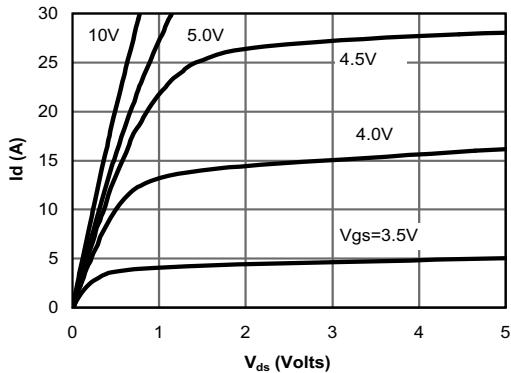
1. The value of R_{θja} is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with T_a=25°C. The value in any given applications depends on the user's specific board design, The current rating is based on the t ≤ 10s thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The R_{θja} is the sum of the thermal impedance from junction to lead R_{θjl} and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_a=25°C. The SOA curve provides a single pulse rating.



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■ Typical electrical and thermal characteristics



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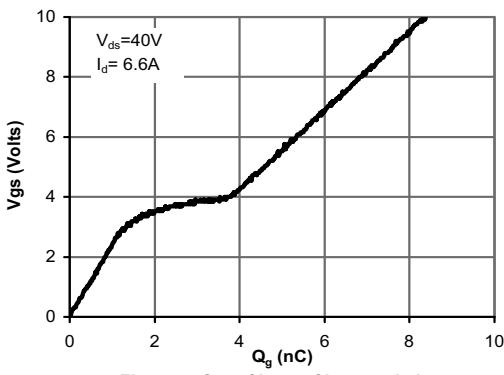


Figure 7: Gate-Charge Characteristics

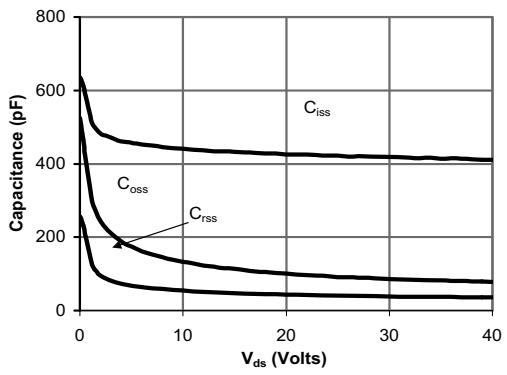


Figure 8: Capacitance Characteristics

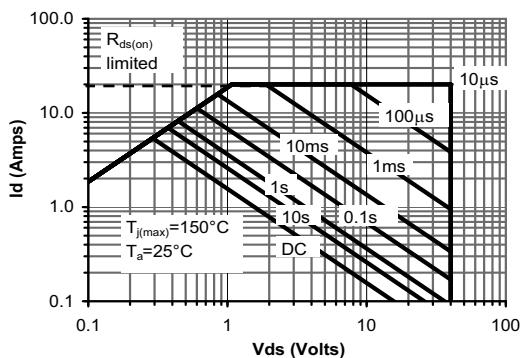


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

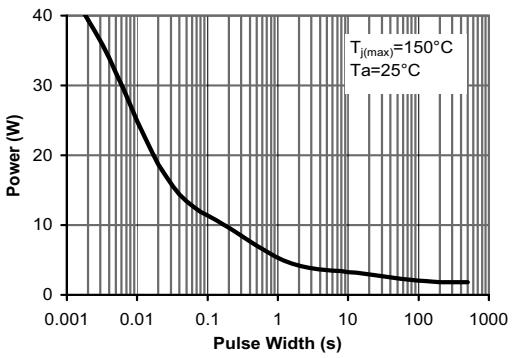


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

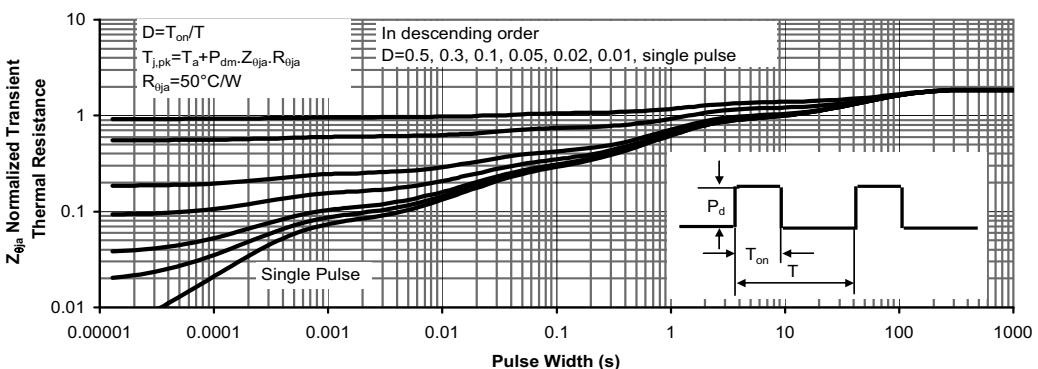


Figure 11: Normalized Maximum Transient Thermal Impedance